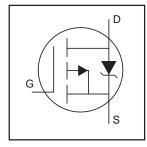
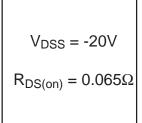
International Rectifier

IRLML6402

HEXFET® Power MOSFET

- Ultra Low On-Resistance
- P-Channel MOSFET
- SOT-23 Footprint
- Low Profile (<1.1mm)
- Available in Tape and Reel
- Fast Switching





Description

These P-Channel MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low onresistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET® power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in battery and load management.

A thermally enhanced large pad leadframe has been incorporated into the standard SOT-23 package to produce a HEXFET Power MOSFET with the industry's smallest footprint. This package, dubbed the Micro3™, is ideal for applications where printed circuit board space is at a premium. The low profile (<1.1mm) of the Micro3 allows it to fit easily into extremely thin application environments such as portable electronics and PCMCIA cards. The thermal resistance and power dissipation are the best available.



Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain- Source Voltage	-20	V
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ -4.5V	-3.7	
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ -4.5V	-2.2	Α
I _{DM}	Pulsed Drain Current ①	-22	
P _D @T _A = 25°C	Power Dissipation	1.3	W
P _D @T _A = 70°C	Power Dissipation	0.8	VV
	Linear Derating Factor	0.01	W/°C
E _{AS}	Single Pulse Avalanche Energy⊕	11	mJ
V_{GS}	Gate-to-Source Voltage	± 12	V
T _J , T _{STG}	Junction and Storage Temperature Range	-55 to + 150	°C

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient®	75	100	°C/W

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Donomoton	B.41:	T	Mari	I Imita	Conditions
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-20		_	V	$V_{GS} = 0V, I_D = -250\mu A$
$\Delta V_{(BR)DSS}\!/\!\Delta T_J$	Breakdown Voltage Temp. Coefficient		-0.009		V/°C	Reference to 25°C, I_D = -1mA @
R _{DS(on)}	Static Drain-to-Source On-Resistance		0.050	0.065	Ω	$V_{GS} = -4.5V, I_D = -3.7A$ ②
US(on)	Statio Brain to Godree On Registerioe		0.080	0.135	52	V _{GS} = -2.5V, I _D = -3.1A ②
V _{GS(th)}	Gate Threshold Voltage	-0.40	-0.55	-0.95	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
g _{fs}	Forward Transconductance	6.0			S	V _{DS} = -10V, I _D = -3.7A ②
1	Drain-to-Source Leakage Current			-1.0		$V_{DS} = -20V, V_{GS} = 0V$
I _{DSS}	Dialii-to-Source Leakage Current			-25	μA	$V_{DS} = -20V, V_{GS} = 0V, T_{J} = 70^{\circ}C$
lasa	Gate-to-Source Forward Leakage			-100	nA	V _{GS} = -12V
I _{GSS}	Gate-to-Source Reverse Leakage			100	IIA	V _{GS} = 12V
Qg	Total Gate Charge		8.0	12		I _D = -3.7A
Q _{gs}	Gate-to-Source Charge		1.2	1.8	nC	$V_{DS} = -10V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		2.8	4.2		V _{GS} = -5.0V ②
t _{d(on)}	Turn-On Delay Time		350			V _{DD} = -10V
t _r	Rise Time		48		ns	$I_D = -3.7A$
t _{d(off)}	Turn-Off Delay Time		588		115	$R_G = 89\Omega$
t _f	Fall Time		381			$R_D = 2.7\Omega$
C _{iss}	Input Capacitance		633			$V_{GS} = 0V$
Coss	Output Capacitance		145		pF	$V_{DS} = -10V$
C _{rss}	Reverse Transfer Capacitance		110			f = 1.0MHz

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			-1.3		MOSFET symbol
	(Body Diode)			-1.3	Α	showing the
I _{SM}	Pulsed Source Current			00		integral reverse
	(Body Diode) ①			-22		p-n junction diode.
V _{SD}	Diode Forward Voltage			-1.2	V	$T_J = 25$ °C, $I_S = -1.0$ A, $V_{GS} = 0$ V ②
t _{rr}	Reverse Recovery Time		29	43	ns	$T_J = 25^{\circ}C, I_F = -1.0A$
Q _{rr}	Reverse RecoveryCharge		11	17	nC	di/dt = -100A/µs ②

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Pulse width \leq 400 μ s; duty cycle \leq 2%.
- ③ Surface mounted on 1" square single layer 1oz. copper FR4 board, steady state.

^{**} For recommended footprint and soldering techniques refer to application note #AN-994.

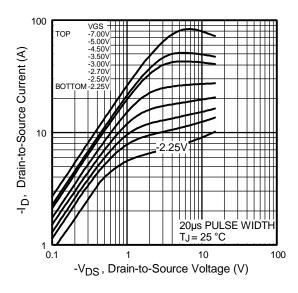


Fig 1. Typical Output Characteristics

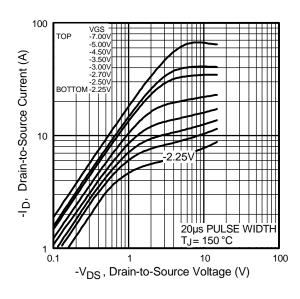


Fig 2. Typical Output Characteristics

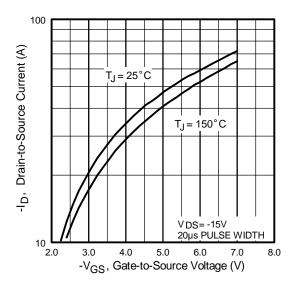


Fig 3. Typical Transfer Characteristics

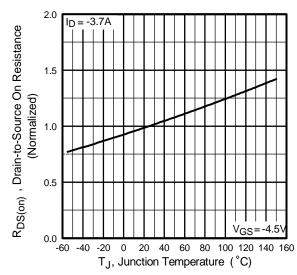


Fig 4. Normalized On-Resistance Vs. Temperature

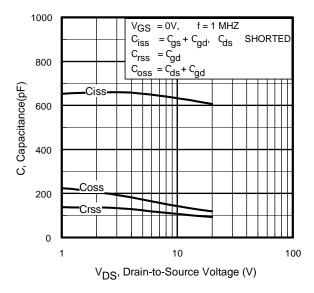


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

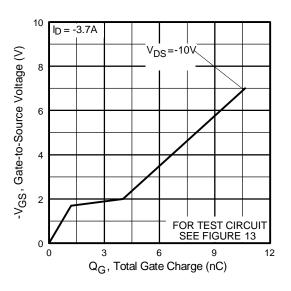


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

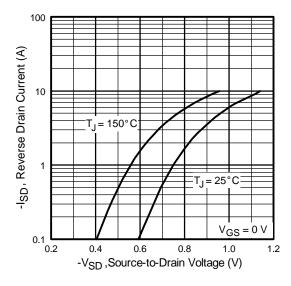


Fig 7. Typical Source-Drain Diode Forward Voltage

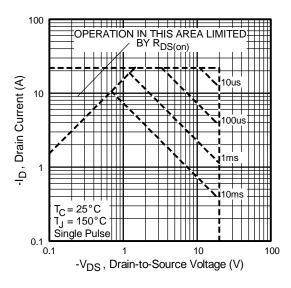
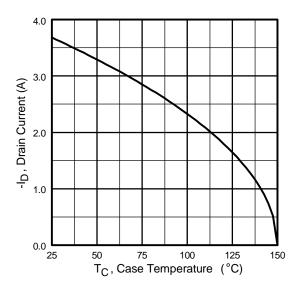


Fig 8. Maximum Safe Operating Area



25 TOP -1.7A -3.0A BOTTOM -3.7A BOTTOM -3.7A -3.0A -3

Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10. Maximum Avalanche Energy Vs. Drain Current

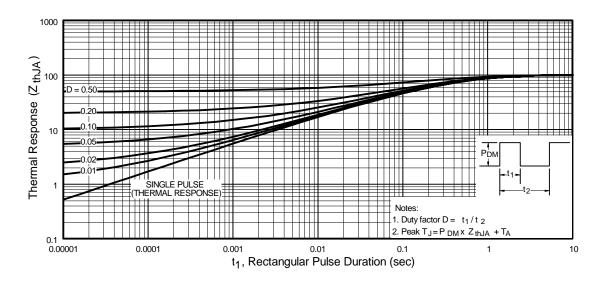
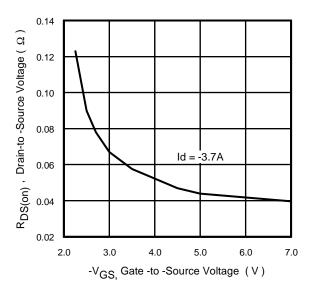


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



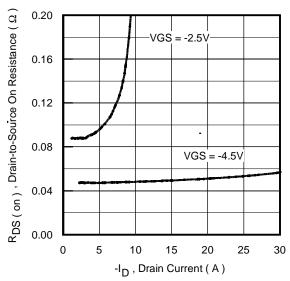


Fig 12. Typical On-Resistance Vs. Gate Voltage

Fig 13. Typical On-Resistance Vs. Drain Current

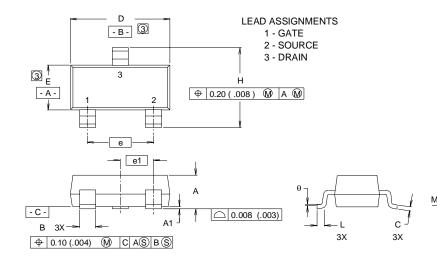
International IOR Rectifier

IRLML6402

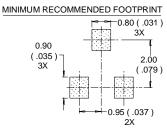
Package Outline

Micro3™

Dimensions are shown in millimeters (inches)



DIM	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	.032	.044	0.82	1.11	
A1	.001	.004	0.02	0.10	
В	.015	.021	0.38	0.54	
С	.004	.006	0.10	0.15	
D	.105	.120	2.67	3.05	
е	.0750 BASIC		1.90 BASIC		
e1	.0375	BASIC	0.95 B	ASIC	
Е	.047	.055	1.20	1.40	
Н	.083	.098	2.10	2.50	
L	.005	.010	0.13	0.25	
θ	0° 8°		0°	8°	



NOTES:

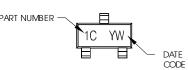
- 1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1982.
 2. CONTROLLING DIMENSION: INCH.
 3 DIMENSIONS DO NOT INCLUDE MOLD FLASH.

Part Marking Information

Micro3™

Notes: This part marking information applies to devices produced before 02/26/2001

WW = (1-26) IF PRECEDED BY LAST DIGIT OF CALENDAR YEAR EXAMPLE: THIS IS AN IRLML6302



Part number —		<u> </u>	
	1C	YW	DATE CODE

PART NUMBER CODE REFERENCE:

1A = IRLML2402 1B = IRLML2803 1C = IRLML6302 1D = IRLML5103 1E = IRLML6402 1F = IRLML6401 1G= IRLML2502

DATE CODE EXAMPLES:

1H = IRLML5203

YWW = 9503 = 5C YWW = 9532 = EF

YEAR	Υ	WORK WEEK	W
2001	1	01	Α
2002	2	02	В
2003	3	03	С
1994	4	04	D
1995	5	1	
1996	6		
1997	7		
1998	8	1	1
1999	9	7	7
2000	0	24	Χ
		25	Υ
		26	Z

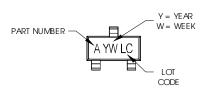
International IOR Rectifier

WW = (27-52) IF PRECEDED BY A LETTER

\/E AD	.,	WORK	14/
YEAR	Y	WEEK	W
2001	Α	27	Α
2002	В	28	В
2003	С	29	С
1994	D	30	D
1995	Ε		
1996	F		
1997	G		
1998	Н	1	1
1999	J	7	7
2000	K	50	X
		51	Υ
		52	Z

Notes: This part marking information applies to devices produced after 02/26/2001

W = (1-26) IF PRECEDED BY LAST DIGIT OF CALENDAR YEAR



PART NUMBER CODE REFERENCE:

A = IRLML2402 B = IRLML2803C = IRLML6302 D = IRLML5103E = IRLML6402F = IRLML6401G= IRLML2502 H = IRLML5203

YEAR	Υ	WORK WEEK	W	
2001	1	01	Α	
2002	2	02	В	
2003	3	03	С	
1994	4	04	D	
1995	5			
1996	6			
1997	7			
1998	8	1	1	
1999	9	7	7	
2000	0	24	Χ	
		25	Υ	
		26	Z	

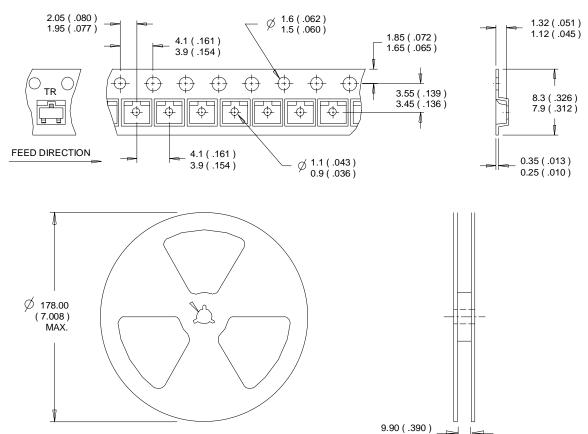
W = (27-52) IF PRECEDED BY A LETTER

YEAR	Υ	WORK WEEK	W
2001	Α	27	Α
2002	В	28	В
2003	С	29	С
1994	D	30	D
1995	Е		
1996	F		
1997	G		
1998	Н		
1999	J	7	1
2000	K	50	X
		51	Υ
		52	Z

Tape & Reel Information

Micro3™

Dimensions are shown in millimeters (inches)



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice.

8.40 (.331)



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